N um erical study of the disorder-driven roughening transition in an elastic manifold in a periodic potential

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W e investigate the roughening phase transition of a (3 + 1)-dimensional elastic manifold driven by the completion between a periodic pinning potential and a random ly distributed in purities. The elastic manifold is modeled by a solid-on-solid type interface model, and universal features of the transition from a at phase (for strong periodic potential) to a rough phase (for strong disorder) are studied at zero temperature using a combinatorial optimization algorithm technique. We mad a continuous transition with a set of num erically estimated critical exponents that we compare with analytic results and those for a periodic elastic medium.

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Extended objects embedded in a higher-dimensional space, like polymers, magnetic ux lines, surfaces, interfaces or dom ain walls, are on large length scales com m only described by elastic m odels, the so-called elastic manifolds (EM) [1]. If quenched disorder in form of im purities or other random ly distributed pinning centers is present, the EM will be, even at low tem peratures or in the absence of any therm al uctuations, in a rough state. However, a periodic array of pinning potentials, like a background lattice potential, increases the tendency of the EM to m in im ize their elastic energy, i.e. to stay at [2, 3]. Both mechanism compete with each other and by varying their relative strength a roughening transition m ight em erge. The num erical investigation of such a scenario is the purpose of this paper.

Consider a d-dimensional EM in a (d+ 1)-dimensional medium with quenched impurities distributed random ly. F luctuations of the shape of the EM are then described by a scalar displacement eld (r) denoting a deviation from a at reference state in the (d+ 1)th direction at each r 2 R^d; ((r);r) refers to the (d+ 1)-dimensional coordinate of an EM segment. It is known that quenched disorder, no matter how weak, destabilizes the at phase for d < 4 [4]. The emerging disordered rough phase is characterized by a divergent displacement correlation function B (r) h[(r) (0)]² i with the distance r = jrj whose scaling property is universal.

An example of the 1D EM is a directed polymer or a magnetic ux line in a disordered 2D plane. Using a mapping to the Kardar-Parisi-Zhang equation for surface growth, it is shown analytically that the displacement correlation diverges algebraically as

B (r)
$$r^2$$
 (1)

with the exactly-known roughness exponent $=\frac{2}{3}$ [1]. For higher-dimensional EMs, analytic studies using a functional renormalization group (FRG) method predict that the rough phase is governed by a zero-tem perature

xed point which is also characterized by a power-law divergence of B (r) as in Eq. (1) [5, 6] and the roughness exponent is found to be = 0.2083 + 0 (²) [5] or $\frac{2}{9} + 0$ (²) [6] up to rst order in = 4 d. These

values are in good agreement with numerical estimates obtained from exact ground-state calculations for (2 + 1) and (3 + 1) D solid-on-solid type interface models [7, 8].

In addition to random in purities, also the structure of the embedding medium can a ect the large scale properties of the EM. In particular, if the medium has a crystalline structure, the EM is pinned by the disorder potential and by the periodic crystal potential, both e ects competing with each other | the latter favoring a at state while the form er a rough one. Hence, the EM m ay undergo a phase transition at a critical disorder-potential strength. Follow ing a qualitative perturbative scaling argum ent [3], one can see that there exists the disorderdriven roughening transition at nonzero disorder strength for 2 < d < 4.

In 2D, the disorder potential is argued to dom inate over the periodic potential marginally [2, 3]. Consequently the 2D EM is believed to be rough at any disorder strength asymptotically beyond a certain length scale which diverges exponentially with the inverse of a disorder strength. Some numerical studies support such claim [9]. On the other hand, it has been reported that an Ising dom ain wall in a (2+1)D lattice with bond dilution displays a roughening transition at a non-zero dilution probability [8]. It suggests that the type of disorder m ight be important in the marginal 2D case (see also discussions in R ef. [9]).

In 3D, the existence of a roughening transition was shown in the studies using a Gaussian variational (GV) method [2] and a FRG method [3, 10]. In the GV study, the free energy was calculated by approximating the Hamiltonian of the EM with a Gaussian. It leads to a conclusion that the transition is of st order. On the other hand, the FRG study with a perturbative expansion in the periodic potential strength and in = 4 d yields that the transition is continuous with a correlation length exponent $= 1 = (2^{-})$. To clarify this issue we perform ed in this work a num erical study of the disorderdriven roughening transition of the 3D elastic manifold in a crystal potential with quenched random im purities.

The EM is described by the Ham iltonian [3]

$$H = \frac{Z}{d^{d}r} \frac{h}{2} \dot{r} (r) f + V_{P} ((r)) + V_{R} ((r);r) ; (2)$$

where the $rst term represents a surface tension, V_{4}$ () =

V cos the periodic lattice potential, and $V_{\rm R}$ (;r) the quenched random potential. Here ~ is measured in units of a_0 = (2 $\,$) with a_0 the lattice constant of the crystal. For uncorrelated distribution of impurities, $V_{\rm R}$ (;r) can be taken as a random variable with mean zero and variance given by

$$\overline{V_{R}(;r)V_{R}(";r^{0})} = D^{2}R(")(r r^{0})$$
 (r r^{0}) (3)

with a parameter D for the disorder strength. Uncorrelated distribution of impurities implies that the disorder correlation function in the (d + 1)th direction is also short-ranged, i.e., R() = ().

It is interesting to note that the H am iltonian in Eq. (2) can also describe so-called periodic elastic media (PEM) in a crystal with quenched disorder [3]. A system of strongly interacting particles or other ob jects, like m agnetic ux lines in a type-II superconductor or a charge density in a solid, will order at low temperatures into a regular arrangem ent, namely, the ux line lattice (FLL) or the charge density wave (CDW), respectively. Fluctuations either induced by them al noise or by disorder induce deviations of the individual particles from their equilibrium positions. As long as these uctuations are not too strong, an expansion of the interaction energy around these equilibrium con guration might be appropriate. An expansion up to second order leads to the surface-tension-like term as in Eq. (2). In contrast to the EM, the PEM have their own periodicity . It im plies that the disorder potential V_R (;r) should be a periodic function in with the periodicity $p = \frac{1}{a_0}$ (commensurability parameter), even though the impurities are distributed random ly. Hence, the disorder correlation function in Eq. (3) should be periodic: R(+ 2 p) = R(). In 3D, as a result of the periodicity, the displacement correlation function for ' =p diverges logarithm ically as h['(r) '(0)]²i' 2A lnrwith a universal coe cient A ' 1:0 in the rough phase [11, 12, 13]. The periodic elastic media also display a disorder-driven roughening transition as a result of com petition between the periodic potential and the random potential. However, there is a slight controversy regarding the nature of the transition since an analytic FRG study [14] and a zero-tem perature num erical study [13] yield results that are not fully com patible.

W e introduce a discrete solid-on-solid (SOS) type interface m odel for the elastic m anifold whose continuum H am iltonian is given in Eq. (2). Locally the EM remains

at in one of periodic potential minim a at = 2 h with integer h. Due to uctuations, some regions might shift to a di erent minimum with another value of h to create a step (or domain wall) separating domains. To minim ize the cost of the elastic and periodic potential energy in Eq. (2), the domain-wallwidth must be nite, say $_{\circ}$ [3]. Therefore, if one neglects uctuations in length scales less than $_{\circ}$, the continuous displacement eld (r) can be replaced by the integer height variable fh_xg representing a (3 + 1) D SOS interface on a simple cubic lattice with sites x 2 fl;::;Lg³. The lattice constant is of order $_{\circ}$ and set to unity. The energy of the interface is given by the H am iltonian

$$H = \int_{h_{x},y_{1}}^{X} J_{(h_{x},x);(h_{y},y_{1})} h_{x} \quad h_{y} j \qquad V_{R} (h_{x};x); \quad (4)$$

where the rst sum is over nearest neighbor site pairs. A fler the coarse graining, the step energy J > 0 as well as the random pinning potential energy V_R becomes a quenched random variable distributed independently and random ly. Note the PEM has the same H am iltonian as in Eq. (4) with random but periodic J and V_R in h with periodicity p [13]. In this sense, the elastic manifold emerges as in the limit p ! 1 of the periodic elastic medium.

Here, we are interested only in the ground state property. Since the prevalent RG-picture suggests that the roughening transition is described by a zero tem perature

xed point [3, 10, 11] one expects the critical exponents we nd to be valid for the nite tem perature roughening transition as well. To nd the ground state, one maps the 3D SOS model onto a ferrom agnetic random bond Ising model in (3 + 1)D hypercubic lattice with anti-periodic boundary conditions in the extra dimension [7] (for the 3 space direction one uses periodic boundary conditions instead). The anti-periodic boundary conditions force a dom ain wall into the ground state con guration of the (3+1)D ferrom agnet. Note that bubbles are not present in the ground state. A dom ain wallm ay contain an overhang which is unphysical in the interface interpretation. Fortunately, one can forbid overhangs in the Ising m odel representation using a technique described in Ref. [7]. If the longitudinal and transversal bond strengths are assigned with J=2 and V_R =2 occurring in Eq. (4), respectively, this dom ain wall of the ferrom agnet becom es equivalent to the ground state con guration of (4) for the interface with the same energy. The domain wall with the lowest energy is then determ ined exactly by using a combinatorial optim ization algorithm, a so-called max- ow/min-cost algorithm. This combinatorial optim ization technique is now adays standard in the study of disordered system s and we refer readers to Ref. [15] for a detailed review.

W e perform ed the ground state calculation on L^3 H hypercubic lattices for L 32. H, the size in the extra direction, is taken to be larger than the interface width. Several distributions for J and V_R were studied for the critical behavior of a disordered system may depend on the choice of the disorder distribution as in the random

eld Ising system [16]. However, our main numerical results do not depend on the speci c choice of the distribution. So we only present the results for an exponential distribution for J > 0, P (J) = e $^{J=J_0}=J_0$ and uniform distribution for $0 V_R V_m$ ax. The disorder strength is

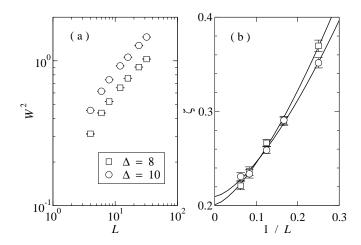


FIG.1: (a) W vs. L in a log-log plot at = 8 and 10 (strong disorder). (b) vs. 1=L for the same values of as in (a). The solid lines are least square ts to the form (L) = $+ aL^{-b}$. We obtain $= 0.21 \ 0.01$ and the resulting value of b' 1.5 > 1 indicates that the extrapolation is stable against statistical uncertainties.

controlled with the parameter $V_{m\ ax}{=}J_0$. O ther distributions studied include (bim odal,bim odal) and (uniform ,uniform) distributions for (J;V_R), and gave identical estimates for the critical exponents.

The state of the interface is characterized by the width W de ned as W² = $h_x^2 i_o h_x i_o^2$, where h o dienotes the spatial average in the ground state and the disor der average. W² is proportional to the spatial integral of the displacement correlation function. We also measure a magnetization-like quantity m $je^{i h_x} i_o j$. It is analogous to the magnetization of the PEM [I3]. One expects that m is non-zero in the at phase and vanishes in the rough phase. So it can be used as an order parameter for the roughening transition.

We rst exam ine the power-law scaling behavior of the width, W L, in the rough phase at large disorder strength = 8 and 10. Figure 1 (a) shows the width average over 1000 5000 disorder realizations for L = 4 32. A noticeable curvature in the loglog plot indicates that corrections to scaling are still rather strong. Nevertheless, we can estim ate the roughness exponent by extrapolating an e ective exponent

(L) = $\log [W (2L)=W (L)] = \log 2$ to the lim it L ! 1 by tting it to a form (L) = $+ aL^{b}$, see Fig. 1 (b). We obtain that

$$= 0.21 \quad 0.01 :$$
 (5)

This value is consistent with the previous analytical and num erical results [5, 6, 7, 8].

As the disorder strength decreases, the width also decreases and the interface eventually becomes at below a threshold (see Fig. 2). The order parameter also shows an indication of a phase transition around '4:0. Apparently the order parameter decreases continuously.

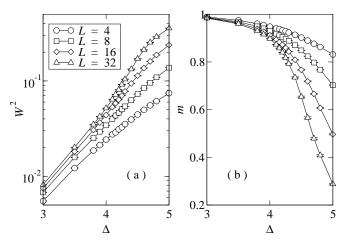


FIG.2: The interface width (a) and the order parameter (b) as functions of at L = 4;8;16, and 32. They are obtained from the disorder average over 3000 20000 samples.

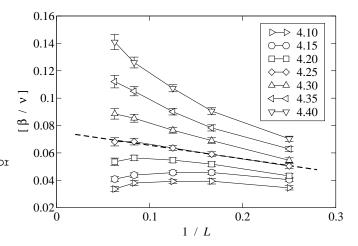


FIG.3: The e ective exponent [=](L) for di erent values of as a function of 1=L. The broken line is a guide for the eyes that separates the curves with a downward bending (< ______) from those with an upward bending (> _______).

Therefore we perform a scaling analysis assuming that the phase transition is a continuous one. The critical point $_{\rm c}$ can be determined from the nite-size-scaling property of the order parameter:

$$m (L;") = L = F ("L1=);$$
 (6)

where " $_{\rm c}$, and () is the order parameter (correlation length) exponent. The scaling function F (x) has a limiting behavior F (x ! 0) = const. so that the order parameter decays algebraically with L L = at the critical point. It also behaves as as m j"j for < c in the F (x ! 1) ixi so that m in nite system size limit. Consider the e ective exponent $[=](L) = \log(m(2L)=m(L)) = \log 2$. It converges to the value of = at the critical point and deviates from it otherwise as L increases. W e estimate the criticalthreshold as the optim alvalue of at which the ef-

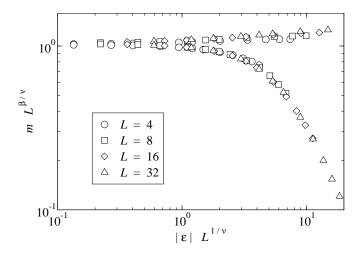


FIG.4: Scaling plot of mL = vs. $j''jL^{1=}$ with "= 4.25, = 0.07, and = 1.4.

fective exponent approaches a nontrivial value. The plot for this e ective exponent is shown in Fig. 3. One can see that there is a downward and upward curvature for < 4.20 and > 4.30, respectively. From this behavior

we estimate that $_{c} = 4.25$ 0.05 and

$$-=0:07$$
 0:03: (7)

Note that the elective exponent varies with L even at the estim ated critical point, which in plies that corrections to scaling are not negligible for system sizes up to L = 32. For that reason our numerical results for $_{\rm c}$ and = have rather large error bars, and one m ay need larger system sizes for better precision. The exponents and could also be obtained from the scaling analysis using Eq. (6). We x the values of $_{\rm c}$ and = to the values obtained before and vary to have an optim al data collapse. We obtain

$$= 1:4 \quad 0:2$$
 (8)

and the corresponding scaling plot is shown in Fig. 4.

The order-param eter scaling property shows that the roughening phase transition is a continuous transition, though the exponent ' 0:1 is very sm all, as opposed to the results of the GV study [2] predicting a rst order transition. The transition nature becomes more transparent by looking at the probability distribution P (m) of the magnetization near the critical point. We measured the distribution from a histogram of the magnetization of 3000 samples with L = 32, which is shown in Fig. 5. We do not observe a double-peak structure in P (m), which would appear for a rst order transition, at any values of . Instead, there is a single peak which shifts continuously toward zero as increases. W e did not observe any double-peak structure in the distribution of the width, either. Therefore we conclude that the roughening transition is the continuous transition.

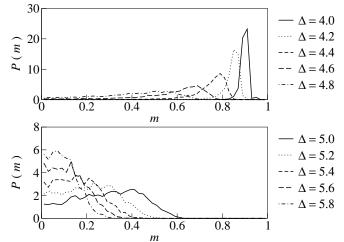


FIG.5: Histogram s for the probability distribution P (m) of the magnetization at L = 32.

We note that this behavior is rem iniscent of the threedimensional random eld Ising-model (RFIM) [17], where also a very small order is found. This causes an extremely weak system s size dependence and the transition appears to be discontinuous in the order parameter although the system is indeed critical and the correlation length diverges. How ever, as has been pointed out in [18] the magnetization of an individual sample shows close to the transition discontinuous jumps when (for a xed eld distribution) the coupling strength is varied (how ever, the sample-averaged magnetization is smooth). Since in the 3d RFIM the maximum jump does not vanish even in the in nite size limit some objection against the continuity of the phase transition has been raised [18]. Since we

nd also a sm allorder param eter exponent { and because of som e m odel speci c sim ilarities between the 3d R F IM and the system we study here | we now want to check the jump size statistics, too.

For a given realization of J and V_R in Eq. (4), we measure the order parameter and its jumps when changing V_R with a global factor. The interface m ay undergo two types of interm ittence: The average height thim ay jump with a vanishing overlap of the interface con gurations before and after the jump (meaning that the whole manifold is in a new position, uncorrelated with the previous one). O ra large dom ain type excitation may appear with only a small change in thi. The interm ittent behavior of (1+1) and (2+1)D interfaces were studied in great detail in R ef. [9]. We want to study how the interface at a given average height roughens, therefore we only take into account the dom ain type excitations with the change in thi less than one half when measuring the jump of the order parameter.

W e calculate the order param eter in the interval 3

7 with spacing 0.02. Figure 6 shows the probability distribution of maximum values of the jump m in 1000 5000 samples of sizes L = 4;6;8;12;16. The inset shows the averaged value. It is non-zero, but becomes smaller

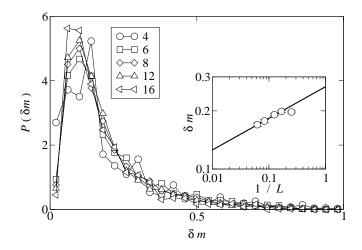


FIG.6: Order parameter jump distribution. Inset shows the plot of the averaged value vs. 1=L in the log-log scale. The solid line has a slope of 0.16.

as the system size increases except for the case of L = 4. The decay is very slow, nevertheless we could t the data for L 6 to a form m L^{0:16} as can be seen in the inset. It suggests that the order parameter jump vanishes in the in nite size limit, and the smallness of the estim ated exponent 0.16 is compatible with our small estim ate for the order parameter .

W e also studied the scaling of the width at the critical point. One m ight expect that the width at the critical point scales as W L with a new roughness exponent ⁰ di erent from ' 0:21 for the rough interface. We plot the e ective exponent = $\log [W (2L)=W (L)] = \log 2$ near the critical point in Fig. 7 (a). One observes that this e ective exponent does not extrapolate to a nonzero value (for com parison c.f. Fig. 1 (b)). Instead, it decreases rapidly as L grows, which suggests rather a logarithm ic scaling, W 2 ' A logL, at the critical point as in the case of the periodic elastic medium [13]. To investigate such a possibility, we measure the prefactor $(W^{2}(2L) W^{2}(L)) = \log 2$ for this logarithm ic scal-Α ing. They are also plotted in Fig. 7 (b), which shows a clear threshold behavior: It decreases (increases) for < 4.25 (> 4.25) and remains constant (A ' 0.03) = 4:25, which was estimated as the critical point at from the order parameter scaling analysis. These facts are consistently suggesting that the interface width scales logarithm ically at the critical point:

$$W^{2}$$
 / 0:03 logL : (9)

The result of the logarithm ic scaling of the width at the critical point agrees wellw ith that of the FRG study [10].

O ur num erical results pose an interesting question: In recent work [13] we found that the disorder-driven roughening transition of the PEM appears to be independent of the commensurability parameter p [13]. A smentioned before, the elastic manifold can be seen as the p ! 1

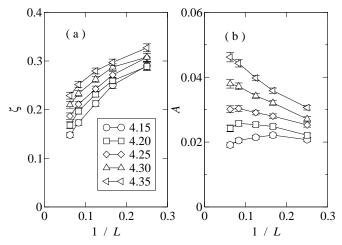


FIG.7: (a) E ective exponent for the power-law behavior of W $\,$ L . (b) P refactor in the logarithm ic scaling of W 2 ' A $\log L$.

lim it of the PEM .Based on this observation one m ight speculate that the roughening transitions of both system sbelong to the same universality class. A lthough the p! 1 -lim it of the PEM could also belong to a di erent universality class the num erical results are compatible with the roughening transition in the EM and the PEM belonging to the same universality class:: For the EM we obtain = '0:07, '1:4, and A '0:03 (W²' A log L at the critical point), while for the PEM [13] we got = '0:05, '1:3, and A '0:018. A lthough these values are very close to each other, a nal conclusion could not be drawn yet due to the rather strong correction to nite size scaling observed in our study of the EM .So we have to leave this issue as an open question.

In sum m ary, we have studied the (3+1)D elastic m anifold in a crystal with quenched random impurities. We have investigated num erically the disorder-driven roughening transition at zero tem perature using an exact com binatorial optim ization algorithm technique. The transition turns out to be continuous with the critical exponents = ' 0:07 and ' 1:4. For a given disorder potential con guration, the order param eter shows a discrete jump for nite size systems when varying its strength. However, the jump vanishes in the in nite system size lim it. W e also found that W 2 scales logarithm ically with the system size L at the critical point, in contrast to the power-law scaling in the rough phase. Our results do not agree with the scenario proposed in R ef. [2] that the roughening transition should be st order. Instead, they are in a qualitative agreem ent with those of FRG -expansion study in Ref. [10], which predicts a continuous roughening transition and a logarithm ic divergence of W 2 at the critical point. However, there is a signi cant discrepancy between the values of the critical exponents obtained num erically and analytically, which was also observed in the study of the PEM [13].

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